

Data Sheet December 21, 2006 FN6299.1

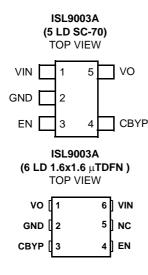
Low Noise LDO with Low IQ, High PSRR

ISL9003A is a high performance single low noise, high PSRR LDO that delivers a continuous 150mA of load current. It has a low standby current and is stable with $1\mu F$ of MLCC output capacitance with an ESR of up to $200m\Omega$.

The ISL9003A has a very high PSRR of 90dB and output noise is $20\mu V_{RMS}$ (typical). When coupled with a no load quiescent current of $31\mu A$ (typical), and $0.5\mu A$ shutdown current, the ISL9003A is an ideal choice for portable wireless equipment.

The ISL9003A comes in many fixed voltage options with ±1.8% output voltage accuracy over temperature, line and load. Other output voltage options are available on request.

Pinouts



Features

- · High performance LDO with 150mA continuous output
- · Excellent transient response to large current steps
- Excellent load regulation:
 <0.1% voltage change across full range of load current
- Very high PSRR: >90dB @ 1kHz
- Wide input voltage capability: 2.3V to 6.5V
- Extremely low quiescent current: 31μA
- Low dropout voltage: typically 200mV @ 150mA
- Low output noise: typically 20μV_{RMS} @ 100μA (1.5V)
- Stable with 1μF to 4.7μF ceramic capacitors
- Shutdown pin turns off LDO with 1μA (max) standby current
- · Soft-start limits input current surge during enable
- · Current limit and overheat protection
- ±1.8% accuracy over all operating conditions
- 5 Ld SC-70 package or 6 Ld μTDFN package
- -40°C to +85°C operating temperature range
- Pb-free plus anneal available (RoHS compliant)

Applications

- · PDAs, cell phones and smart phones
- · Portable instruments, MP3 players
- · Handheld devices including medical handhelds

ISL9003A

Ordering Information

PART NUMBER (Note 2)	PART MARKING	V _O VOLTAGE (V) (Note 1)	TEMP. RANGE (°C)	PACKAGE Tape and Reel (Pb-free)	PKG. DWG. #
ISL9003AIENZ-T	СВК	3.3	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIEMZ-T	CBJ	3.0	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIEKZ-T	CCE	2.85	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIEJZ-T	CCD	2.8	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIEHZ-T	CCC	2.75	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIEFZ-T	ССВ	2.5	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIECZ-T	CBY	1.8	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIEBZ-T	CBW	1.5	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIRUBZ-T	L	1.5	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUCZ-T	G	1.8	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUFZ-T	F	2.5	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUHZ-T	Н	2.75	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUJZ-T	J	2.8	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUKZ-T	К	2.85	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUMZ-T	М	3.0	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUNZ-T	N	3.30	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A

NOTES:

- 1. For other output voltages, contact Intersil Marketing.
- Intersil Pb-free plus anneal products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate
 termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are
 MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

ISL9003A

Absolute Maximum Ratings

Recommended Operating Conditions

Ambient Temperature Range (TA)	40°C to +85°C
Supply Voltage (VIN)	2.3 to 6.5\

Thermal Information

Thermal Resistance	θ_{JA} (°C/W)
5 Ld SC-70 Package (Note 3)	231
6 Ld μTDFN Package (Note 4)	
Junction Temperature Range40°	°C to +125°C
Operating Temperature Range40	0°C to +85°C
Storage Temperature Range 65°	°C to +150°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

- 3. θ_{JA} is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief TB379 for details.
- 4. θ_{JA} is measured in free air with the component mounted on a high effective thermal conductivity test board with "direct attach" features. See Tech Brief TB379.

Electrical Specifications

Unless otherwise noted, all parameters are guaranteed over the operational supply voltage and temperature range of the device as follows: $T_A = -40^{\circ}C$ to $+85^{\circ}C$; $V_{IN} = (V_O + 0.5V)$ to 6.5V with a minimum V_{IN} of 2.3V; $C_{IN} = 1\mu F$; $C_O = 1\mu F$; $C_{BYP} = 0.01\mu F$

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
DC CHARACTERISTICS						
Supply Voltage	V _{IN}		2.3		6.5	V
Ground Current	I _{DD}	Output Enabled; I _O = 0μA; V _{IN} < 4.2V		31	40	μА
		Output Enabled; I _O = 0μA; Full voltage range			57	μΑ
Shutdown Current	I _{DDS}			0.5	1.2	μА
UVLO Threshold	V _{UV+}		1.9	2.1	2.3	V
	V _{UV-}		1.6	1.8	2.0	V
Regulation Voltage Accuracy		Initial accuracy at $V_{IN} = V_O + 0.5V$, $I_O = 10$ mA, $T_J = +25$ °C	-0.7		+0.7	%
		$V_{IN} = V_O + 0.5V$ to 6.5V, $I_O = 10\mu A$ to 150mA, $T_J = +25^{\circ} C$	-0.8		+0.8	%
		$V_{IN} = V_O + 0.5V$ to 6.5V, $I_O = 10\mu A$ to 150mA, $T_J = -40^{\circ} C$ to +125°C	-1.8		+1.8	%
Maximum Output Current	I _{MAX}	Continuous	150			mA
Internal Current Limit	I _{LIM}		175	265	355	mA
Drop-out Voltage (Note 6)	V _{DO1}	I _O = 150mA; V _O < 2.5V		300	500	mV
	V _{DO2}	$I_O = 150$ mA; 2.5 V $\leq V_O \leq 2.8$ V		250	400	mV
	V _{DO3}	I _O = 150mA; 2.8V < V _O		200	325	mV
Thermal Shutdown Temperature	T _{SD+}			140		°C
	T _{SD-}			110		°C
AC CHARACTERISTICS	I .					l
Ripple Rejection (Note 5)		$I_O = 10 \text{mA}, V_{IN} = 2.8 \text{V(min)}, V_O = 1.8 \text{V}, C_{BYP} = 0.1 \mu\text{F}$				
		@ 1kHz		90		dB
		@ 10kHz		70		dB
		@ 100kHz		50		dB
Output Noise Voltage (Note 5)		$V_O = 1.5V$, $T_A = +25$ °C, $C_{BYP} = 0.1\mu F$				
		BW = 10Hz to 100kHz, $I_0 = 100\mu$ A		20		μV_{RMS}
		BW = 10Hz to 100kHz, I _O = 10mA		30		μV_{RMS}
DEVICE START-UP CHARACTE	RISTICS	-		•		•
Device Enable Time	T _{EN}	Time from assertion of the EN pin to when the output voltage reaches 95% of the VO(nom).		250	500	μS
LDO Soft-start Ramp Rate	T _{SSR}	Slope of linear portion of LDO output voltage ramp during start-up		30	60	μs/V

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Electrical Specifications

Unless otherwise noted, all parameters are guaranteed over the operational supply voltage and temperature range of the device as follows: T_A = -40°C to +85°C; V_{IN} = (V_O +0.5V) to 6.5V with a minimum V_{IN} of 2.3V; C_{IN} = 1 μ F; C_O = 1 μ F; C_{BYP} = 0.01 μ F (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS	
EN PIN CHARACTERISTICS							
Input Low Voltage	V_{IL}		-0.3		0.4	٧	
Input High Voltage	V _{IH}		1.4		V _{IN} +0.3	V	
Input Leakage Current	I _{IL} , I _{IH}				0.1	μΑ	
Pin Capacitance	C _{PIN}	Informative		5		pF	

NOTES:

- 5. Guaranteed by design and characterization
- 6. $V_O = 0.98 * V_O(NOM)$; Valid for V_O greater than 1.85V.

Typical Performance Curves

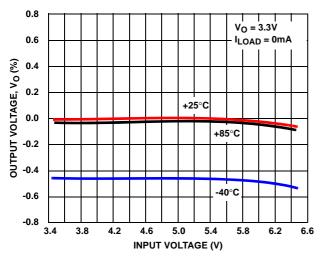


FIGURE 1. OUTPUT VOLTAGE vs INPUT VOLTAGE (3.3V OUTPUT)

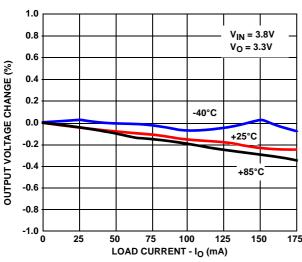


FIGURE 3. OUTPUT VOLTAGE vs LOAD CURRENT

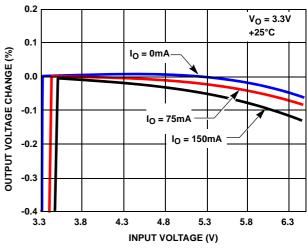


FIGURE 2. OUTPUT VOLTAGECHANGE (%) vs INPUT VOLTAGE (3.3V OUTPUT)

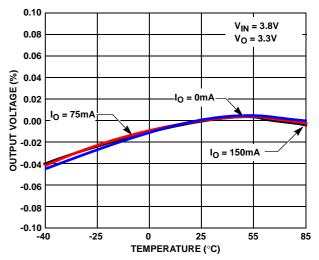


FIGURE 4. OUTPUT VOLTAGE vs TEMPERATURE

Typical Performance Curves (Continued)

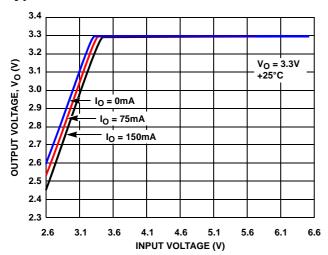


FIGURE 5. DROPOUT VOLTAGE vs INPUT VOLTAGE (3.3V OUTPUT)

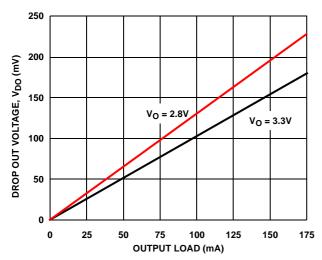


FIGURE 7. DROPOUT VOLTAGE vs LOAD CURRENT

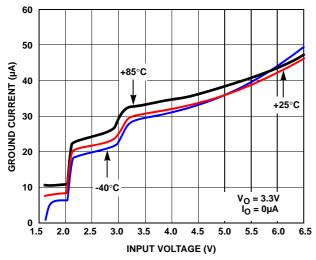


FIGURE 9. GROUND CURRENT vs INPUT VOLTAGE

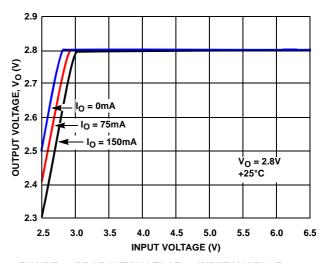


FIGURE 6. DROPOUT VOLTAGE vs INPUT VOLTAGE (2.8V OUTPUT)

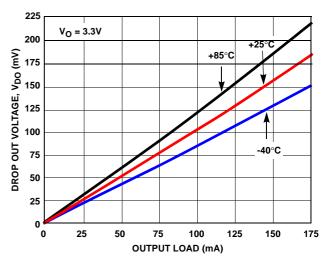


FIGURE 8. DROPOUT VOLTAGE vs LOAD CURRENT

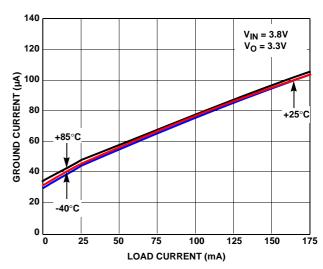


FIGURE 10. GROUND CURRENT vs LOAD

Typical Performance Curves (Continued)

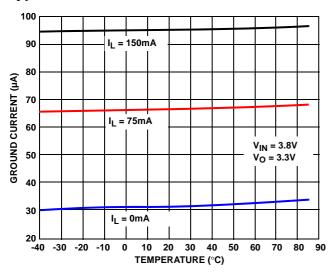


FIGURE 11. GROUND CURRENT vs TEMPERATURE

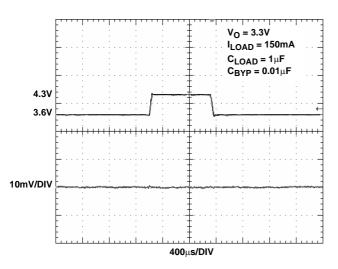


FIGURE 13. LINE TRANSIENT RESPONSE, 3.3V OUTPUT

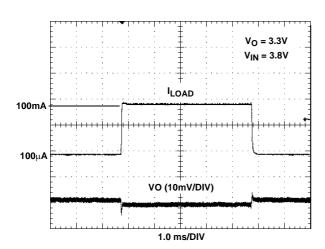


FIGURE 15. LOAD TRANSIENT RESPONSE

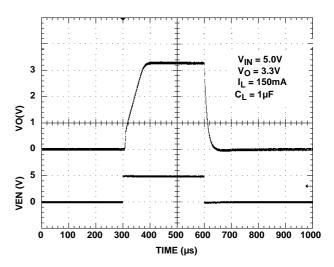


FIGURE 12. TURN ON/TURN OFF RESPONSE

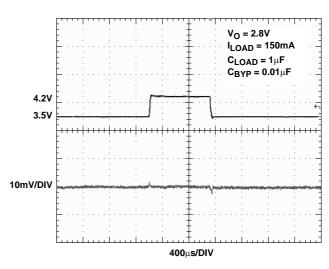


FIGURE 14. LINE TRANSIENT RESPONSE, 2.8V OUTPUT

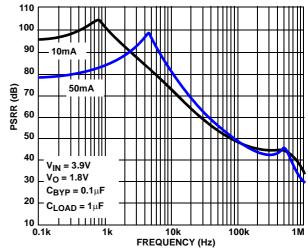


FIGURE 16. PSRR vs FREQUENCY

Typical Performance Curves (Continued)

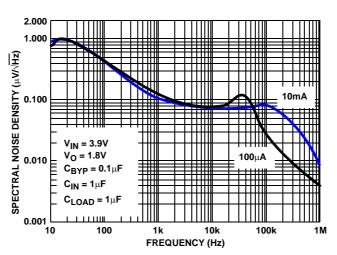
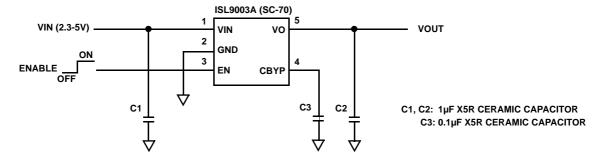


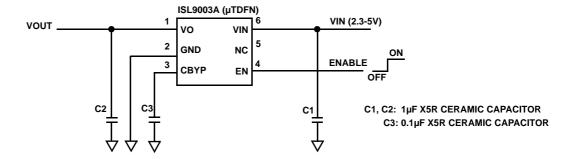
FIGURE 17. SPECTRAL NOISE DENSITY vs FREQUENCY

Pin Description

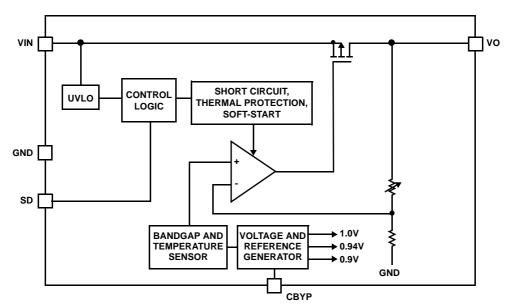
5 LD SC-70 PIN #	6 LD μTDFN PIN #	PIN NAME	DESCRIPTION
1	6	VIN	Supply Voltage/LDO Input. Connect a 1μF capacitor to GND.
2	2	GND	GND is the connection to system ground. Connect to PCB Ground plane.
3	4	EN	Output Enable. When this signal goes high, the LDO is turned on.
4	3	СВҮР	Reference Bypass Capacitor Pin. Optionally connect capacitor of value $0.01\mu F$ to $1\mu F$ between this pin and GND to tune in the desired noise and PSRR performance.
5	1	VO	LDO Output. Connect a 1µF capacitor of value to GND.
-	5	NC	No Connect.

Typical Application





Block Diagram



Functional Description

The ISL9003A contains all circuitry required to implement a high performance LDO. High performance is achieved through a circuit that delivers fast transient response to varying load conditions. In a quiescent condition, the ISL9003A adjusts its biasing to achieve the lowest standby current consumption.

The device also integrates current limit protection, smart thermal shutdown protection, and soft-start. Smart Thermal shutdown protects the device against overheating. Soft-start minimizes start-up input current surges without causing excessive device turn-on time.

Power Control

The ISL9003A has an enable pin, EN, to control power to the LDO output. When EN is low, the device is in shutdown mode. In this condition, all on-chip circuits are off, and the device draws minimum current, typically less than $0.3\mu A.$ When the EN pin goes high, the device first polls the output of the UVLO detector to ensure that VIN voltage is at least 2.1V (typical). Once verified, the device initiates a start-up sequence. During the start-up sequence, trim settings are first read and latched. Then, sequentially, the bandgap, reference voltage and current generation circuitry turn on. Once the references are stable, the LDO powers up.

During operation, whenever the VIN voltage drops below about 1.84V, the ISL9003A immediately disables the LDO output. When VIN rises back above 2.1V (assuming the EN pin is high), the device re-initiates its start-up sequence and LDO operation resumes automatically.

Reference Generation

The reference generation circuitry includes a trimmed bandgap, a trimmed voltage reference divider, a trimmed current reference generator, and an RC noise filter. The filter includes the external capacitor connected to the CBYP pin. A $0.01\mu F$ capacitor connected CBYP implements a 100Hz lowpass filter, and is recommended for most high performance applications. For the lowest noise application, a $0.1\mu F$ or greater CBYP capacitor should be used. This filters the reference noise to below the 10Hz-1kHz frequency band, which is crucial in many noise-sensitive applications.

The bandgap generates a zero temperature coefficient (TC) voltage for the regulator reference and other voltage references required for current generation and overtemperature detection.

A current generator provides references required for adaptive biasing as well as references for LDO output current limit and thermal shutdown determination.

LDO Regulation and Programmable Output Divider

The LDO Regulator is implemented with a high-gain operational amplifier driving a PMOS pass transistor. The design of the ISL9003A provides a regulator that has low quiescent current, fast transient response, and overall stability across all operating and load current conditions. LDO stability is guaranteed for a $1\mu F$ to $4.7\mu F$ output capacitor that has a tolerance better than 20% and ESR less than $200m\Omega$. The design is performance-optimized for a $1\mu F$ capacitor. Unless limited by the application, use of an output capacitor value above $4.7\mu F$ is not recommended as LDO performance improvement is minimal.

ISL9003A

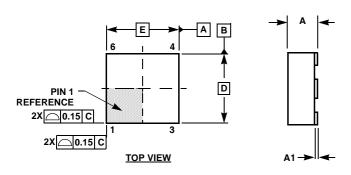
Soft-start circuitry integrated into each LDO limits the initial ramp-up rate to about $30\mu s/V$ to minimize current surge. The ISL9003A provides short-circuit protection by limiting the output current to about 265mA (typ).

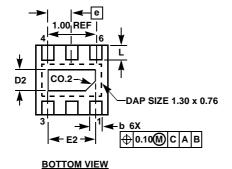
The LDO uses an independently trimmed 1V reference as its input. An internal resistor divider drops the LDO output voltage down to 1V. This is compared to the 1V reference for regulation. The resistor division ratio is programmed in the factory.

Overheat Detection

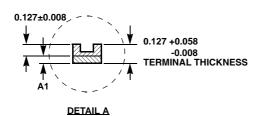
The bandgap outputs a proportional-to-temperature current that is indicative of the temperature of the silicon. This current is compared with references to determine if the device is in danger of damage due to overheating. When the die temperature reaches about +140°C, the LDO momentarily shuts down until the die cools sufficiently. In the overheat condition, if the LDO sources more than 50mA it will be shut off. Once the die temperature falls back below about +110°C, the disabled LDO is re-enabled and soft-start automatically takes place.

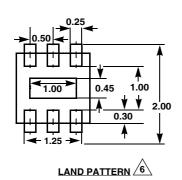
Ultra Thin Dual Flat No-Lead Plastic Package (UTDFN)





6X 0.08 C TIPE A3 C SEATING PLANE





L6.1.6x1.6A6 LEAD ULTRA THIN DUAL FLAT NO-LEAD PLASTIC PACKAGE

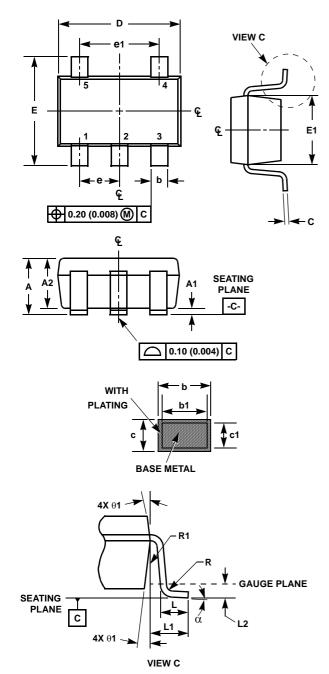
	N			
SYMBOL	MIN	NOTES		
Α	0.45 0.50		0.55	-
A1	-	-		
А3		-		
b	0.15	0.20	0.25	-
D	1.55	1.60	1.65	4
D2	0.40	0.45	0.50	-
Е	1.55	1.60	1.65	4
E2	0.95	-		
е		-		
L	0.25	-		

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NOTES:

- 1. Dimensions are in mm. Angles in degrees.
- Coplanarity applies to the exposed pad as well as the terminals. Coplanarity shall not exceed 0.08mm.
- 3. Warpage shall not exceed 0.10mm.
- 4. Package length/package width are considered as special characteristics.
- 5. JEDEC Reference MO-229.
- 6. For additional information, to assist with the PCB Land Pattern Design effort, see Intersil Technical Brief TB389.

Small Outline Transistor Plastic Packages (SC70-5)



P5.0495 LEAD SMALL OUTLINE TRANSISTOR PLASTIC PACKAGE

	INC	HES	MILLIN				
SYMBOL	MIN	MAX	MIN	MAX	NOTES		
Α	0.031	0.043	0.80	1.10	-		
A1	0.000	0.004	0.00	0.10	-		
A2	0.031	0.039	0.80	1.00	-		
b	0.006	0.012	0.15	0.30	-		
b1	0.006	0.010	0.15	0.25			
С	0.003	0.009	0.08	0.22	6		
c1	0.003	0.009	0.08	0.20	6		
D	0.073	0.085	1.85	2.15	3		
Е	0.071	0.094	1.80	2.40	-		
E1	0.045	0.053	1.15	1.35	3		
е	0.0256 Ref		0.65 Ref		-		
e1	0.051	2 Ref	1.30 Ref		-		
L	0.010	0.018	0.26	0.46	4		
L1	0.017 Ref.		0.420	Ref.	-		
L2	0.006 BSC		0.15 BSC				
α	0°	8 ⁰	0°	8 ⁰	-		
N	5			5	5		
R	0.004	-	0.10	-			
R1	0.004	0.010	0.15	0.25			

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NOTES:

- 1. Dimensioning and tolerances per ASME Y14.5M-1994.
- 2. Package conforms to EIAJ SC70 and JEDEC MO-203AA.
- 3. Dimensions D and E1 are exclusive of mold flash, protrusions, or gate burrs.
- 4. Footlength L measured at reference to gauge plane.
- 5. "N" is the number of terminal positions.
- These Dimensions apply to the flat section of the lead between 0.08mm and 0.15mm from the lead tip.
- 7. Controlling dimension: MILLIMETER. Converted inch dimensions are for reference only.

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